| Search Note | S |
|-------------|---|
| | |

| | Application/Control No. | Applicant(s)/Patent under Reexamination |
|---|-------------------------|---|
| - | 10/072,683 | ZUK ET AL. |
| | Examiner | Art Unit |
| į | Minh Dieu Nauven | 2137 |

| | SEAR | CHED | |
|-------|------------------|-----------|----------|
| Class | Subclass | Date | Examiner |
| 726 | 11-13, 22- 25 | 9/12/2005 | MDN |
| 709 | 238-244 | 9/12/2005 | MDN |
| 713 | 153, 189 | 9/12/2005 | MDN |
| 705 | 51-54 | 9/12/2005 | MDN |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |

| INT | INTERFERENCE SEARCHED | | |
|-------|-----------------------|------|----------|
| Class | Subclass | Date | Examiner |
| | | | |
| | | | |
| | | | |
| | l | | |
| | | | |
| | | | |

| SEARCH NOT (INCLUDING SEARCH | |) |
|---|-----------|------|
| | DATE | EXMR |
| Inventor name search on EAST (US-PAT; US-PG-PUB; EPO; JPO; DERWENT; IBM-TDB) | 9/12/2005 | MDN |
| Text and class search on EAST (US-PAT; US-PG-PUB; EPO; JPO; DERWENT; IBM-TDB) | 9/12/2005 | MDN |
| PLUS search | 9/12/2005 | MDN |
| · | | |
| | | |
| | | |
| | | |
| | | |
| | | : |
| | | |
| | | |